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| Notice of References Cited | Application/Control No. 10/735,335 | Applicant(s)/Patent Under Reexamination MADHAVI ET AL. | |
| | Examiner Matthew L. Fedowitz | Art Unit 1623 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|---------------------|----------------|
| * | A | US-4,929,774 | 05-1990 | Fukamachi et al. | 568/824 |
| | B | US-5,221,735 | 06-1993 | Leuenberger et al. | 536/4.1 |
| | C | US-4,125,630 | 11-1978 | Orthoefer, Frank T. | 426/104 |
| | D | US-6,569,463 | 05-2003 | Patel et al. | 424/497 |
| | E | US- | | | |
| | F | US- | | | |
| | G | US- | | | |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

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